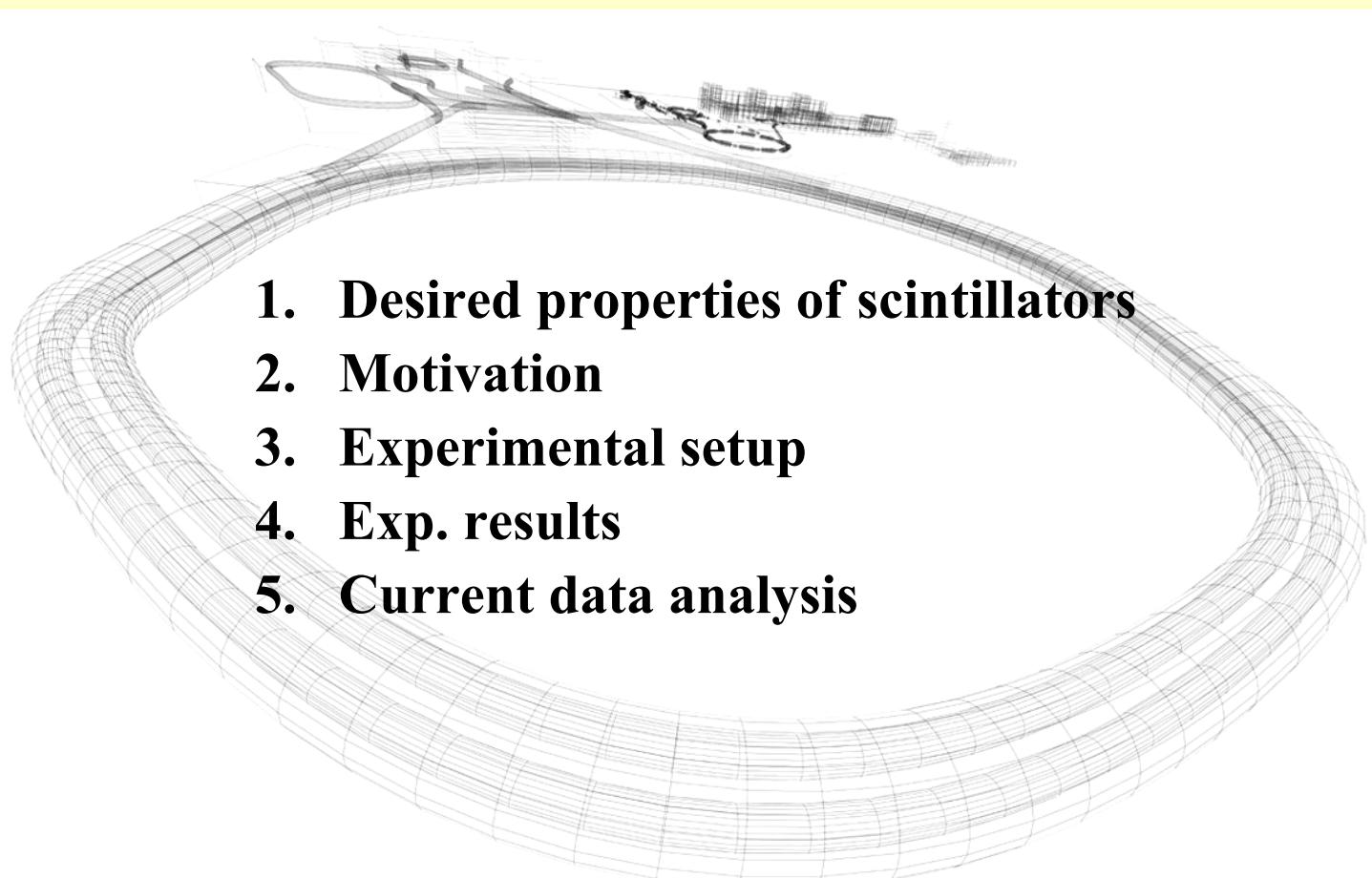


Scintillation screen investigations for high current ion beams

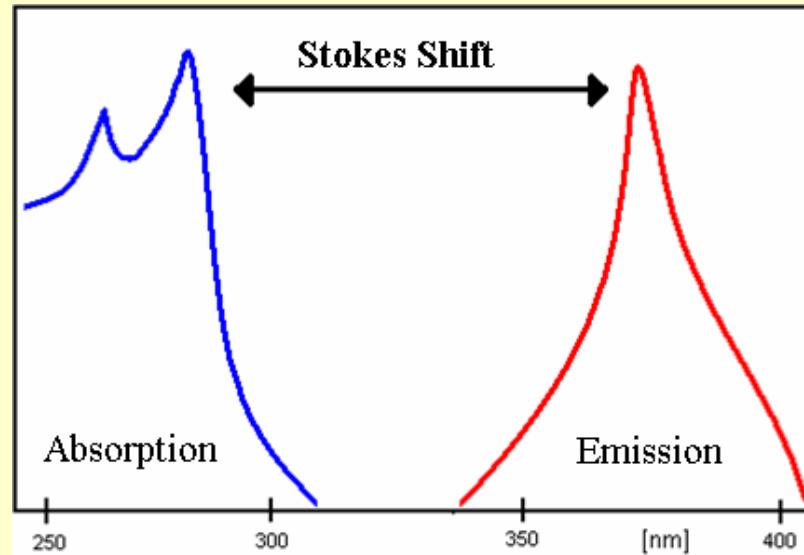
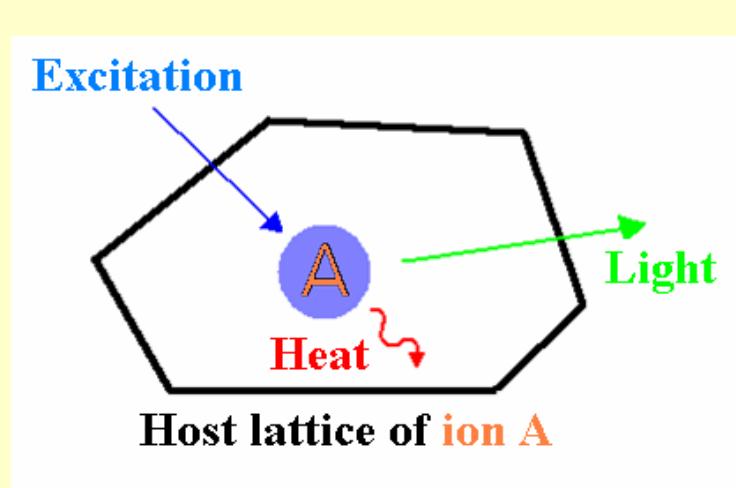
Eiko Gütlich^{1,2}, Peter Forck¹, Wolfgang Ensinger², Beata Walasek-Höhne¹

¹GSI, Darmstadt, Germany ²Technical University Darmstadt, Germany

- 
1. Desired properties of scintillators
 2. Motivation
 3. Experimental setup
 4. Exp. results
 5. Current data analysis

Desired properties of scintillators

- The kinetic energy of the ion is converted into light
- Conversion with good quantum efficiency
- Light yield directly proportional to number of particles
- Small absorption of induced light
- Small temperature dependency of scintillation





Motivation

Scintillator screens are widely used for qualitative measurements:

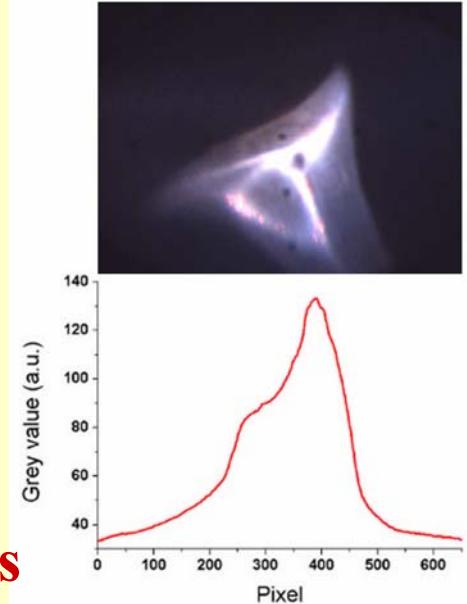
- simple profile measurements system
- complete 2-dimensional beam information (Profile Grid → 2x1D)
- used for beam alignment

But we want to perform quantitative measurements

→ Investigation for high currents :

(some mA, for up to 1 ms @ 11.4 MeV/u → some 100μm range in matter)

- spatial resolution and linearity
- ageing effects
- dynamical behaviour



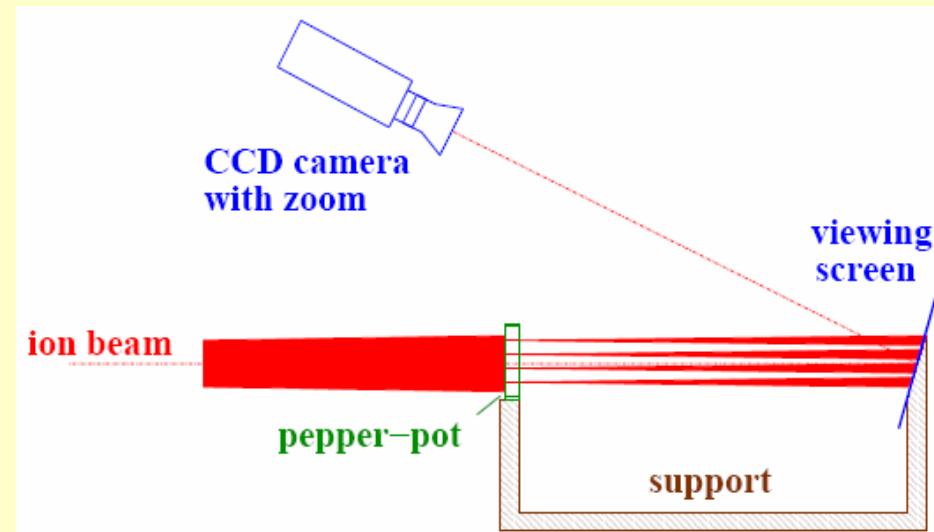
Courtesy of Jan Mäder (GSI)

Possible application

Single shot emittance measurement

-Advantages of the Pepperpot method compared to the Slit-grid method

- gain of complete transversal phase space information from one macro pulse
- much shorter measurement time at the UNILAC Pepperpot: ~1 min.
Slit-Grid: ~30-60 min.
- can be used for machines with low repetition rate



Scintillators / Ion beams

Desired property: high light output

→ Single crystals: YAG:Ce, BGO, CdWO₄, CaF₂:Eu

Quartz glass: Quartz:Ce

Expectation: strong degradation effects for high current ion beams

Desired property: high resistance against high current ion beams

→ Ceramics: ZrO₂, ZrO₂:Mg , Al₂O₃, Al₂O₃:Cr, BN

Quartz glass: Herasil

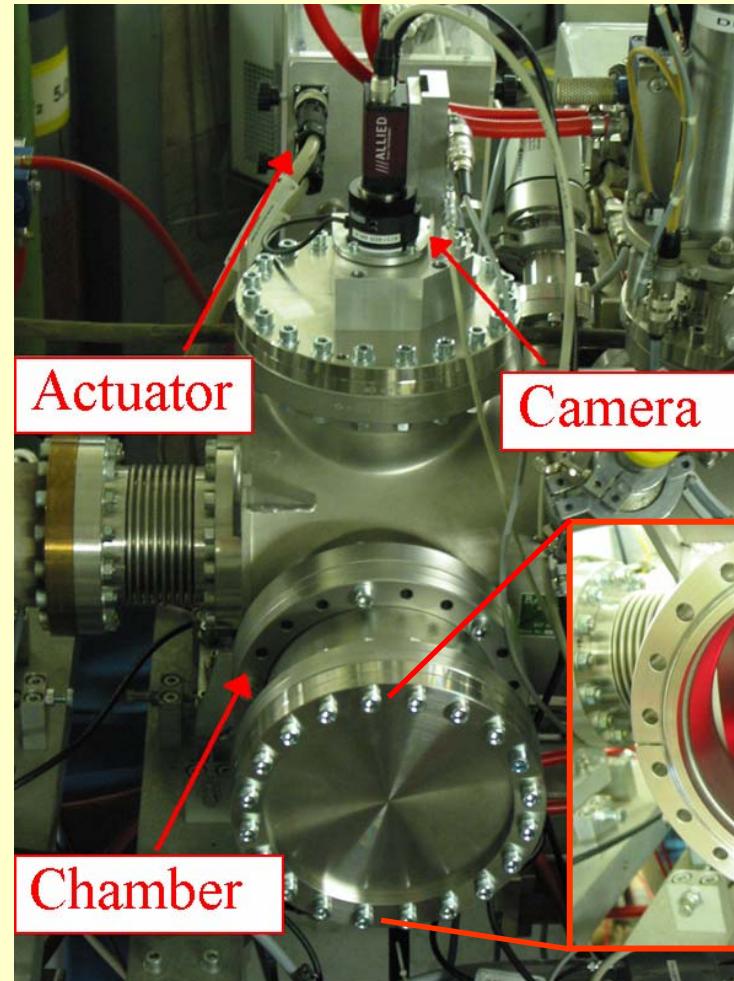
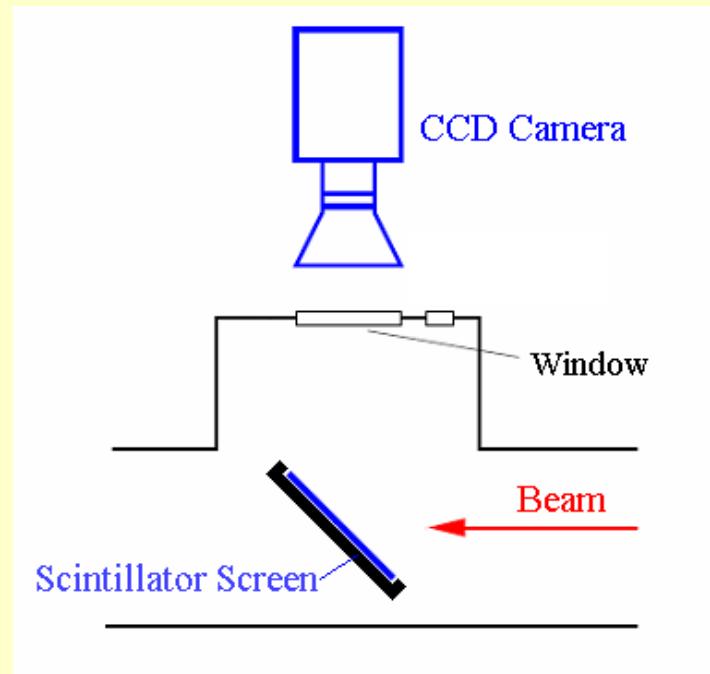
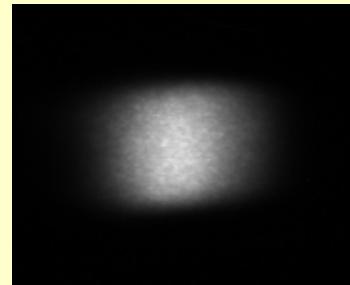
Expectation: low sensitivity

Investigated with H⁺, C²⁺, Ar¹⁰⁺, Ni⁹⁺, Ta²⁴⁺ and U²⁸⁺ Ions with energies between 4.8 and 11.4 MeV/u and beam currents from some nA to some mA.

Experimental setup

Image

10mm



Flange diameter
200 mm

Target holder / Camera

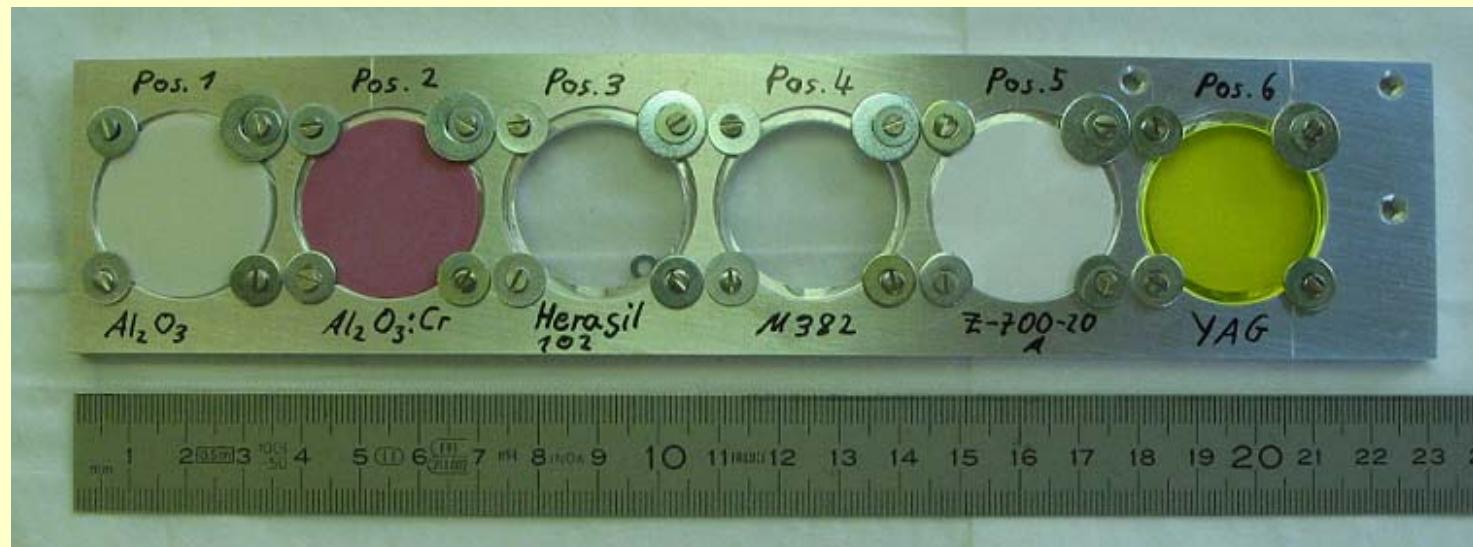
Holder allows to:

- investigate 6 scintillator materials
- in one machine run
- at the same position → constant beam conditions

Camera: AVT Marlin
VGA resolution
8Bit monochromic

Lens system: Pentax 25mm

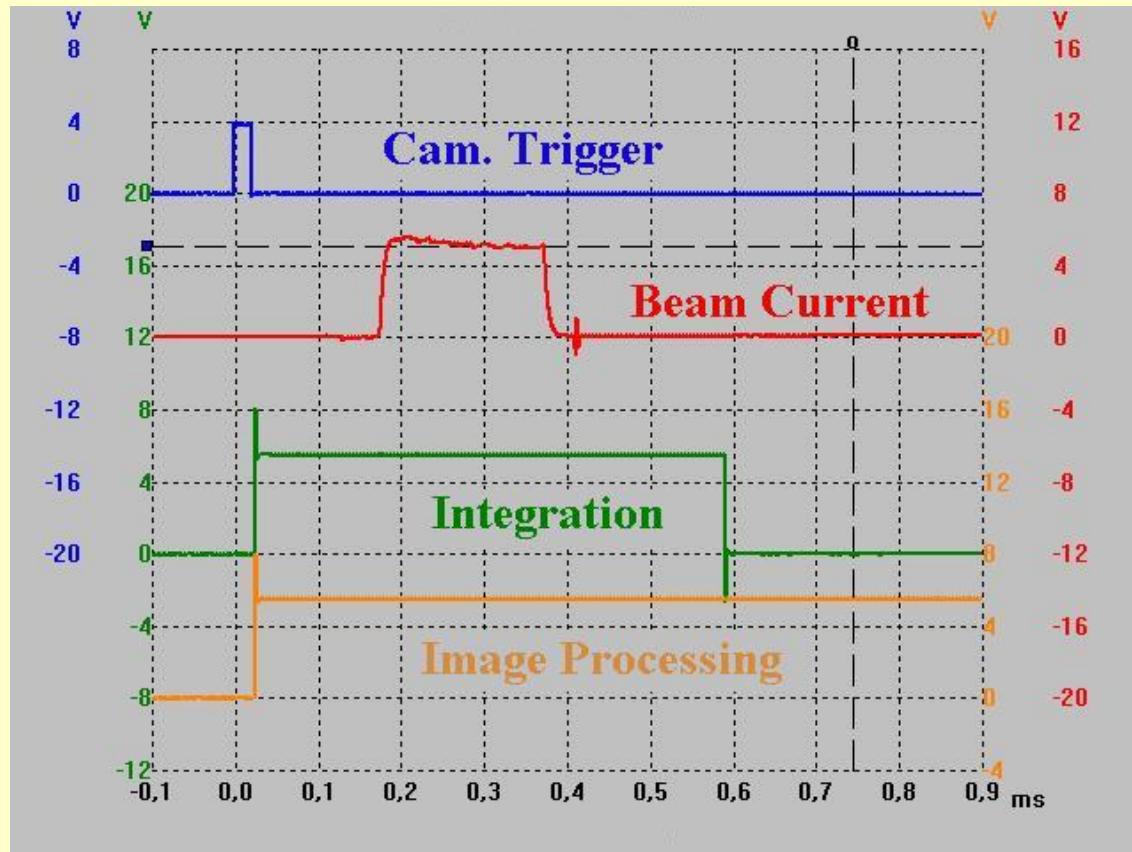
Spatial resolution: 10 Px/mm



Screen dimensions: Ø30mm x 1mm

Camera timing

Camera timing for pulsed ion beam



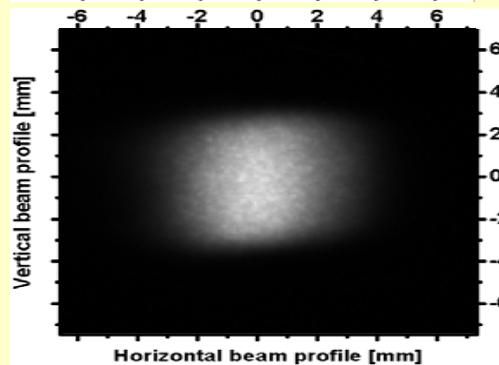
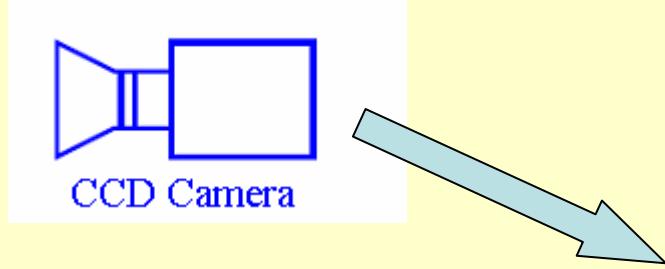
Timing allows:

- to observe complete beam pulse
- measurements of afterglow
- max. 15 Frames /s

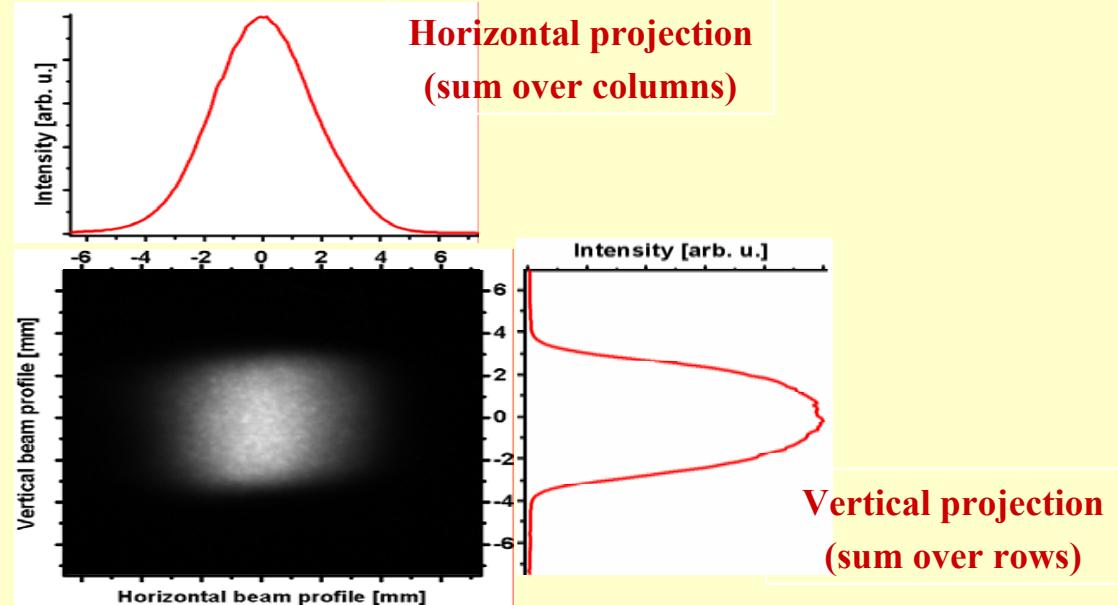
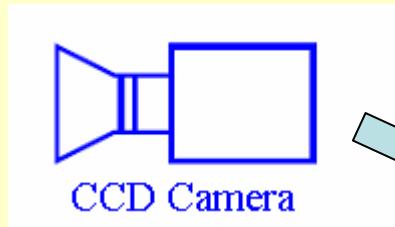
Typical beam delivery:

- pulse length 100 μ s
- repetition 10 per second

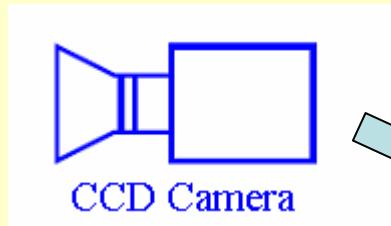
Observed image parameters



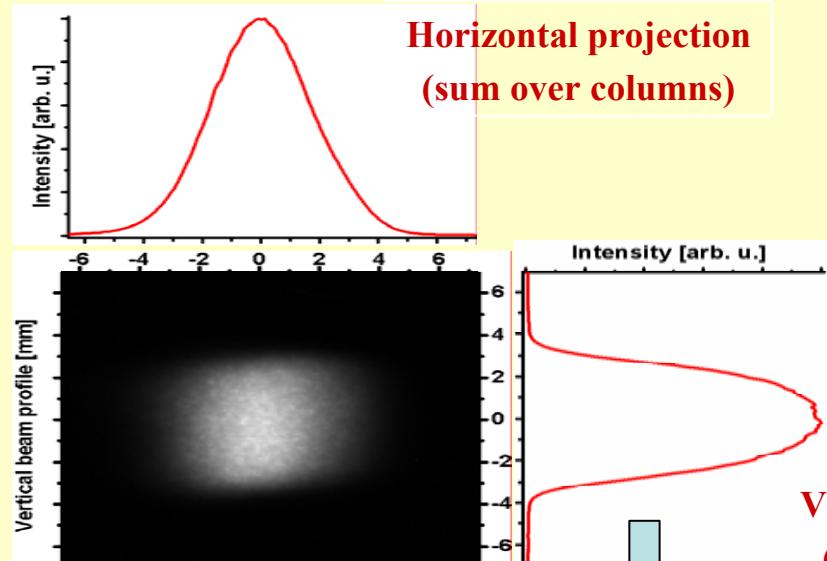
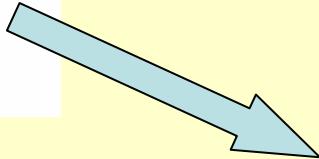
Observed image parameters



Observed image parameters



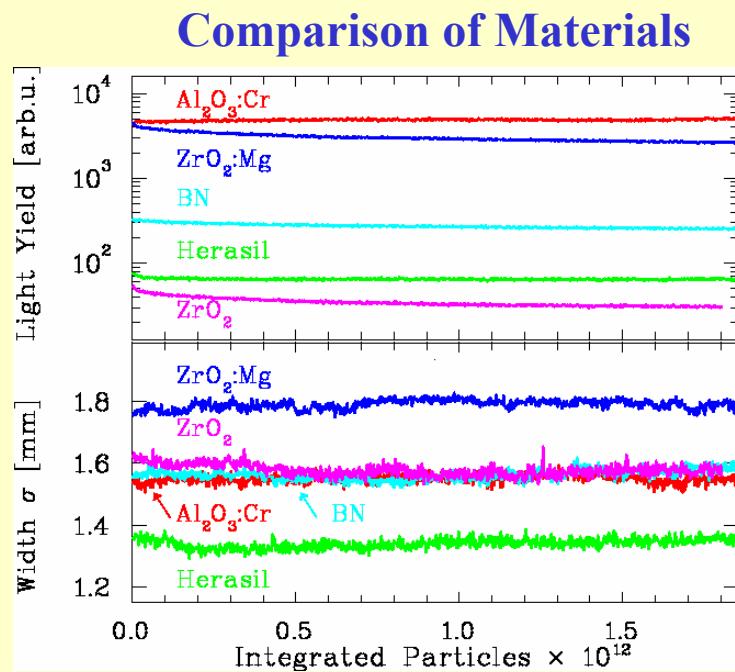
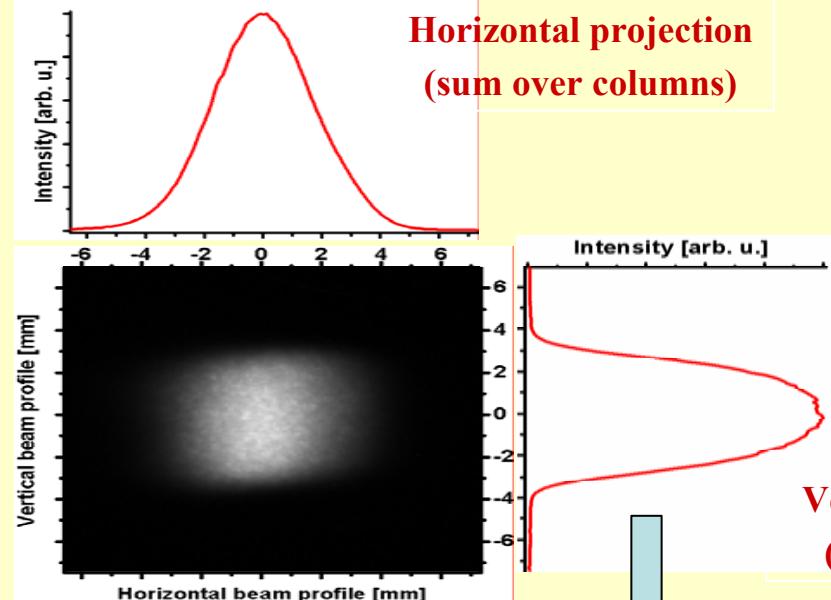
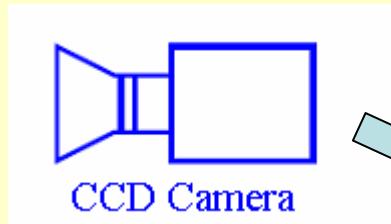
CCD Camera



From the projection:

- Light yield (integral)
- Center of projections (μ , 1st moment)
- Beam width (σ , 2nd moment)
- Skewness (prop. to 3rd moment)
- Kurtosis (prop. to 4th moment)

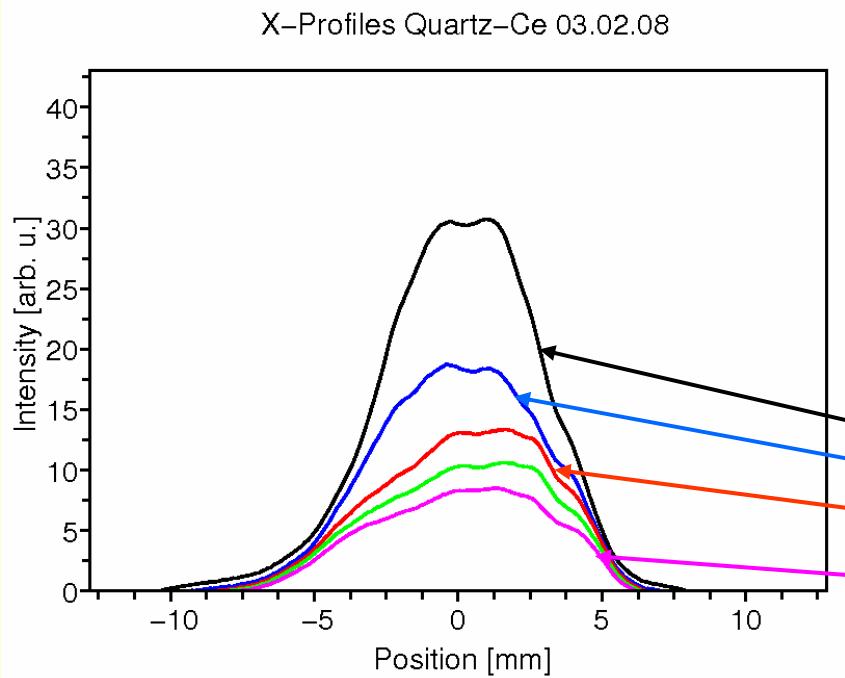
Observed image parameters



From the projection:

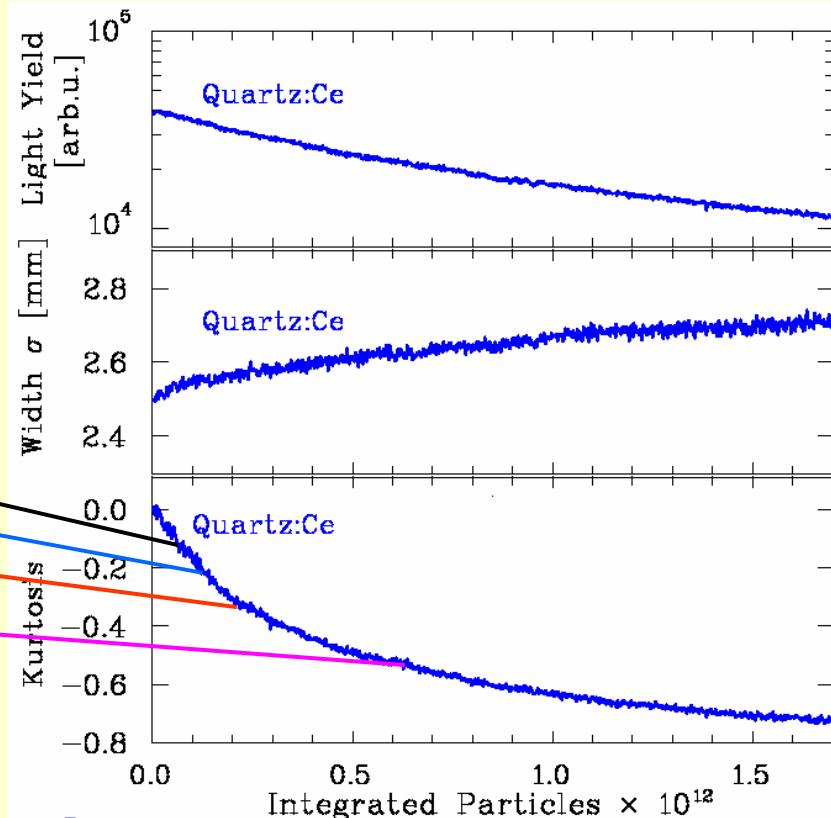
- Light yield (integral)
- Center of projections (μ , 1st moment)
- Beam width (σ , 2nd moment)
- Skewness (prop. to 3rd moment)
- Kurtosis (prop. to 4th moment)

Example for degradation effect



→ Strong profile deformation

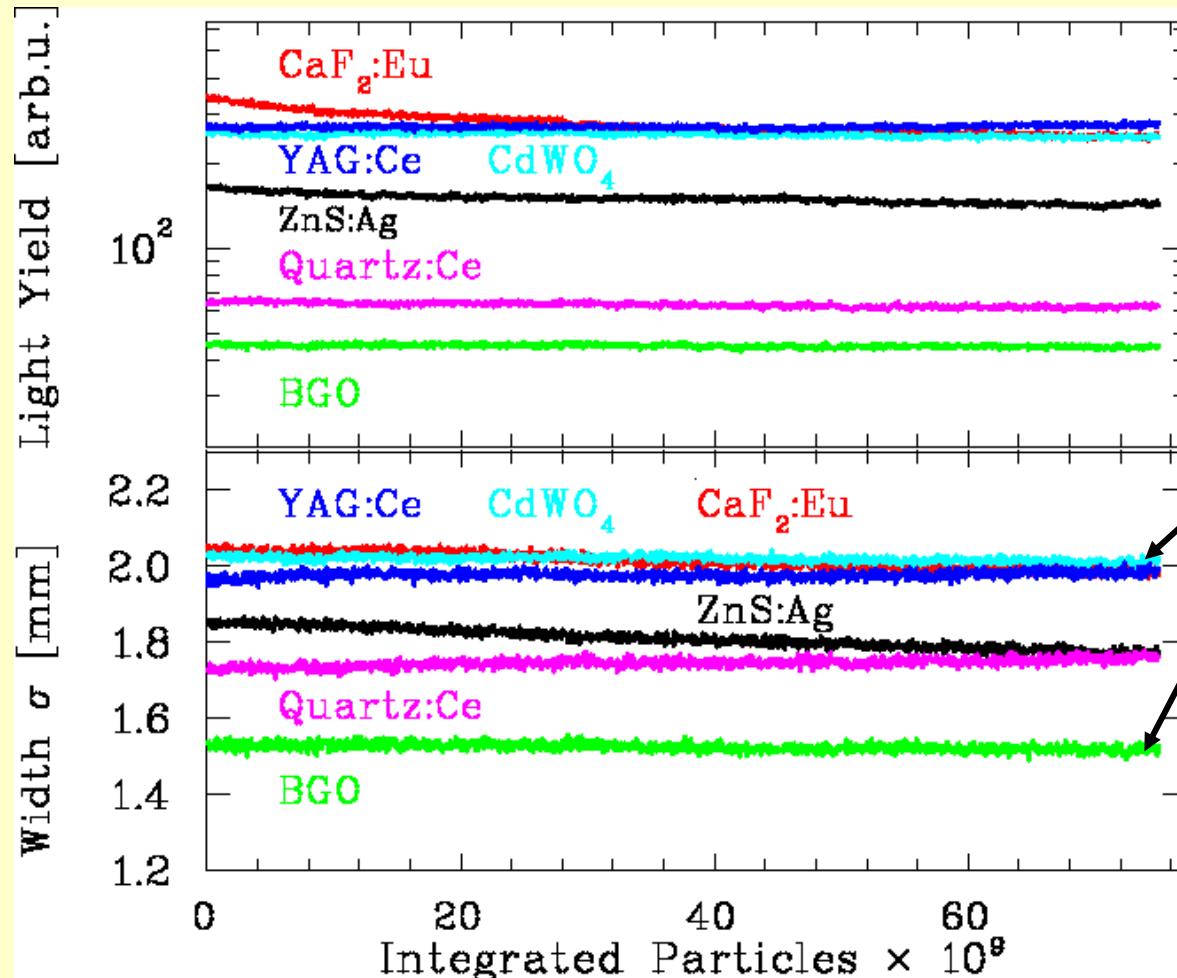
Beam parameters: $^{40}\text{Ar}^{10+}$, 2×10^9
Ions/Pulse in $100\mu\text{s}$, $\sim 30\mu\text{A}$, 1Hz



Results:

- not only the beam width is important
- characterization by first 4 moments

Behaviour of standard scintillators



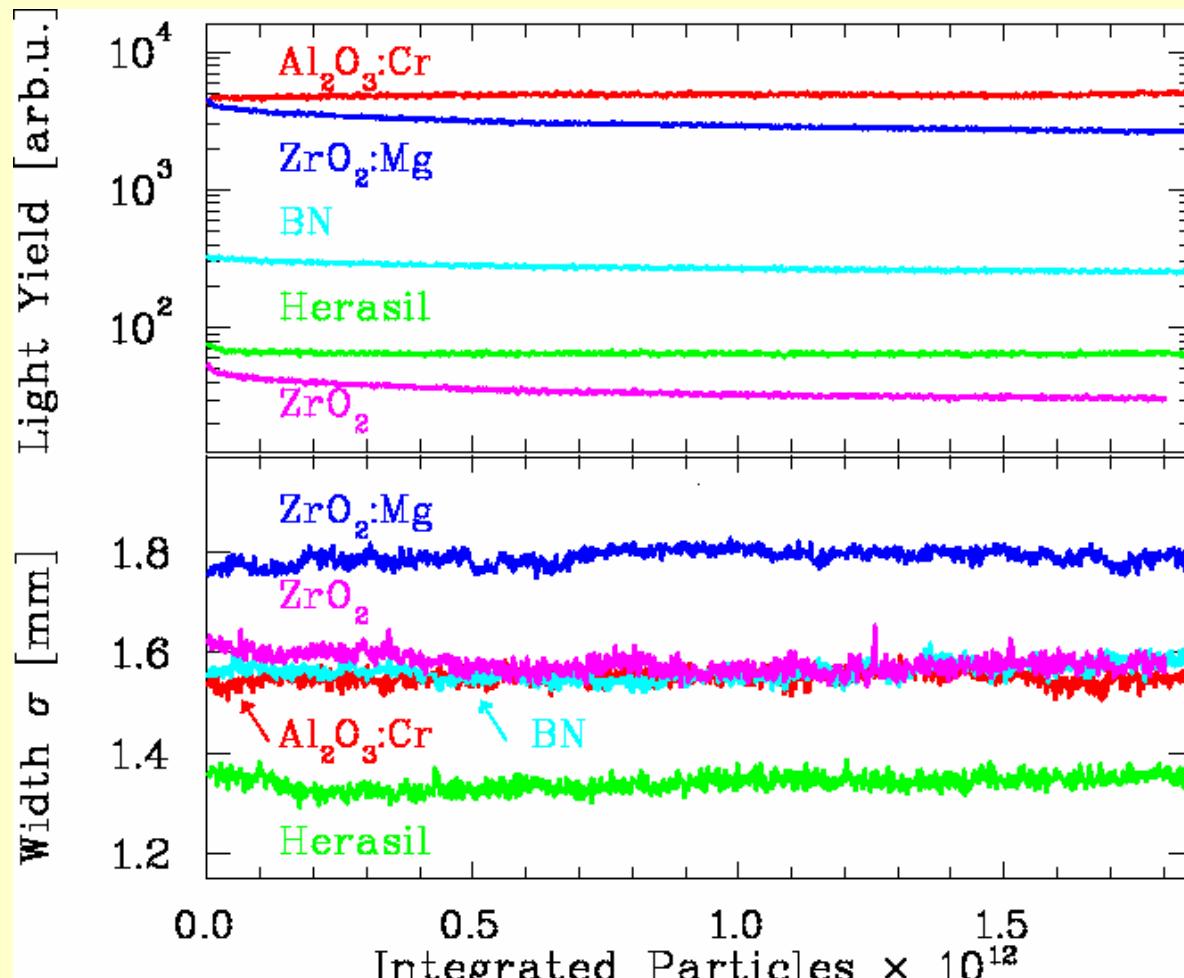
Result:

- even for purpose built scintillators different width reading of 25%
- not suitable for higher currents

Average temperature: 23°C
(backside of ZnS:Ag)

Beam parameters: $^{12}\text{C}^{2+}$, 5×10^6 Ions/Pulse in 100μs, ~17nA, 12.6Hz, 15000 beam pulses

Light yield and profile width @ low intensity



Results:

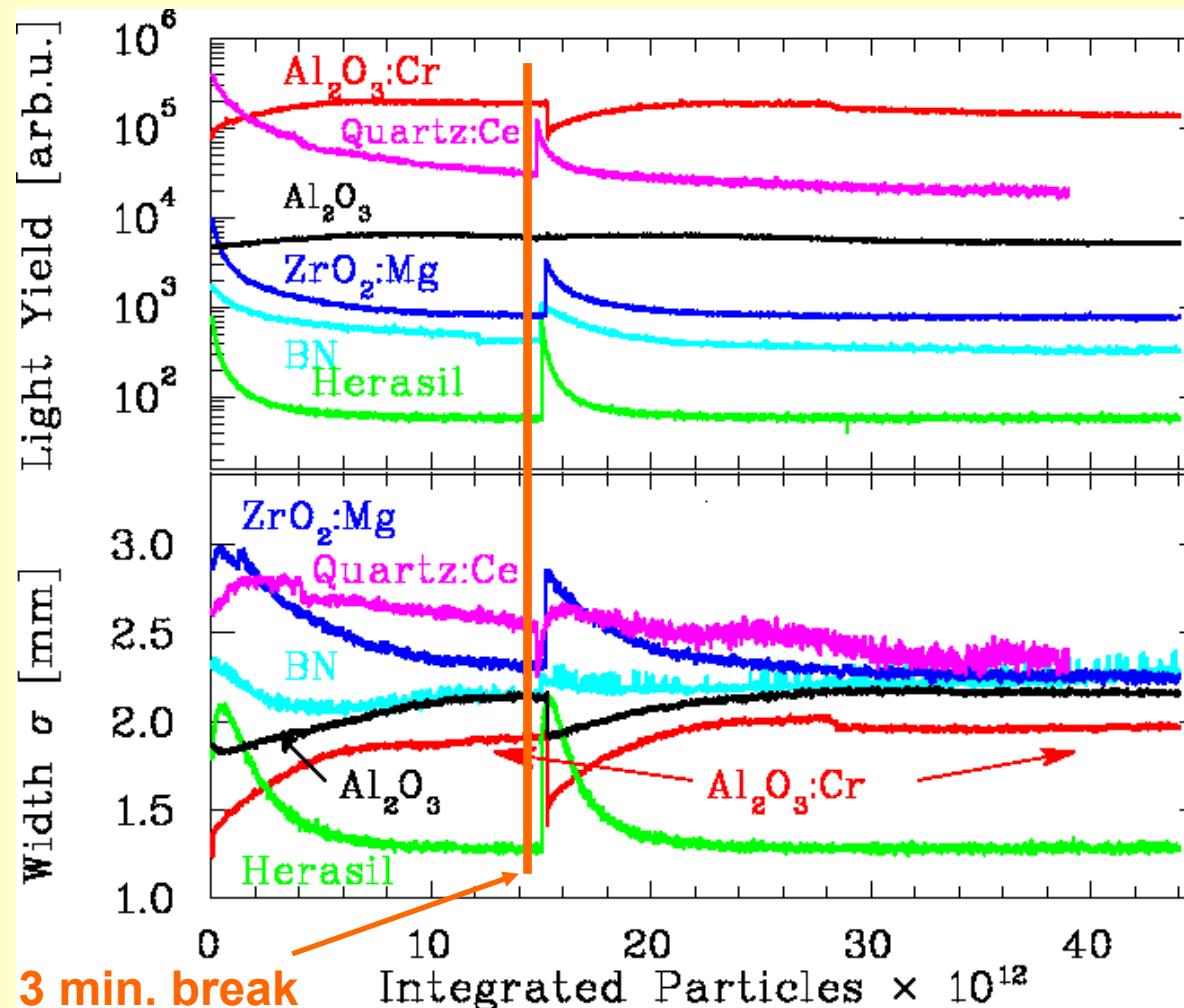
- reproducible behavior
- different light yield and width reading
- light yield does not correlate with beam width
- different beam shape (from higher stat. moments)

Difference of 14% in profile width is not negligible for quantitative evaluation

Average temperature: ~47°C
(backside of $\text{ZrO}_2:\text{Mg}$)

Beam parameters: ${}^{40}\text{Ar}^{10+}$, 2×10^9 Ions/Pulse in 100 μ s, ~30 μ A, 1Hz, 1000 beam pulses

Light yield and profile width @ higher intensity



10 times higher beam current

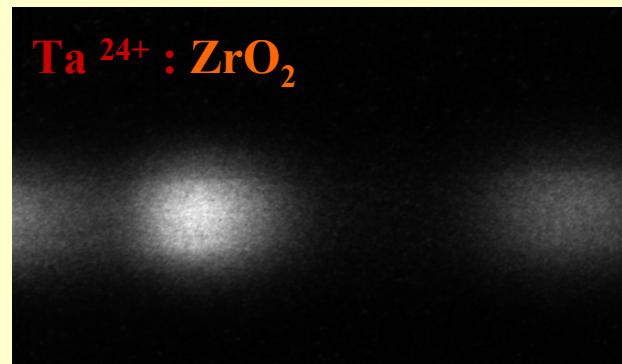
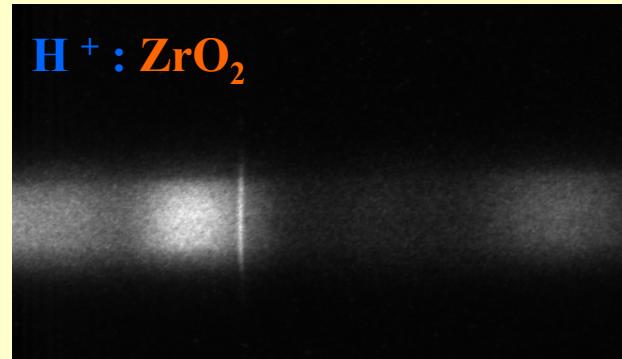
Results:

- light yield and profile width depend on material
- different dynamical behaviour
- possible reasons: surface modification and temperature dependency

Average temperature: $\sim 240^\circ\text{C}$
(backside of $\text{ZrO}_2:\text{Mg}$)

Beam parameters: ${}^{40}\text{Ar}^{10+}$, 2×10^{10} Ions/Pulse in $100\mu\text{s}$, $\sim 0.3\text{mA}$, 2.6Hz , 2200 beam pulses

Spectra of the scintillators @ medium current



— Ta^{24+}
— H^+

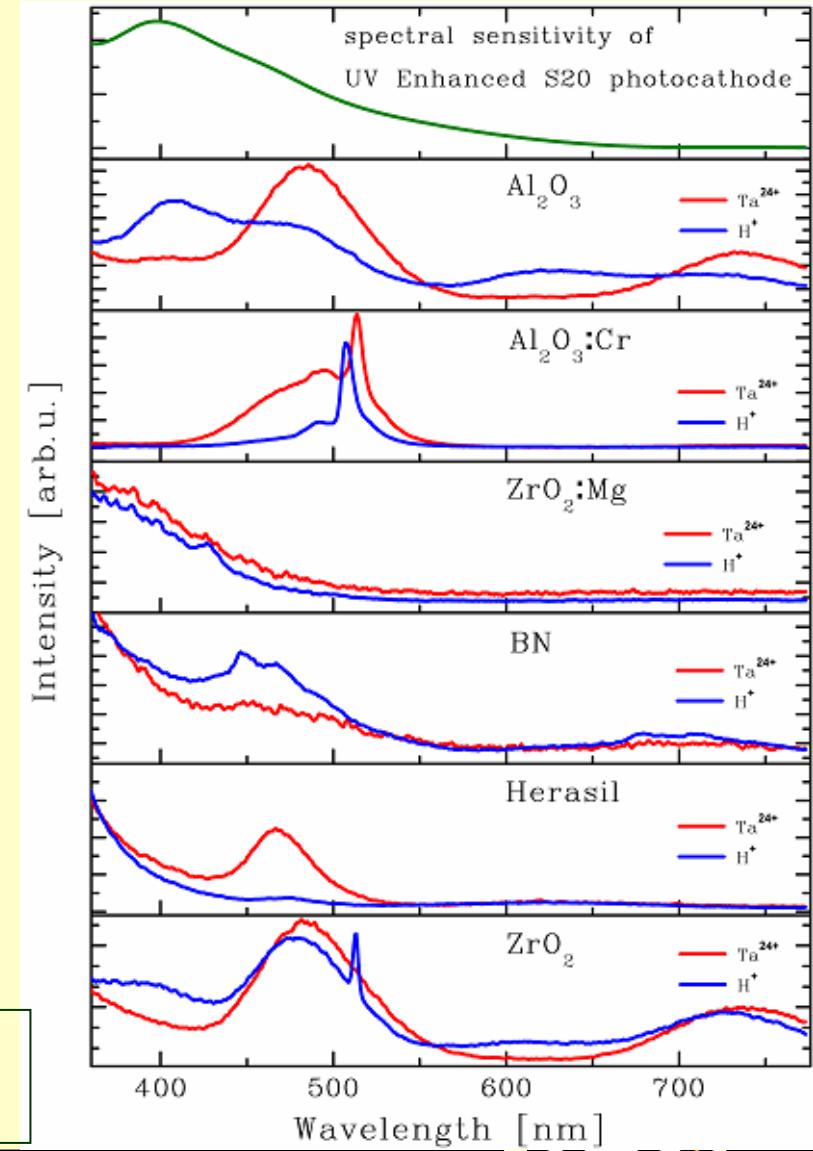
Wavelength [nm] →

Result:

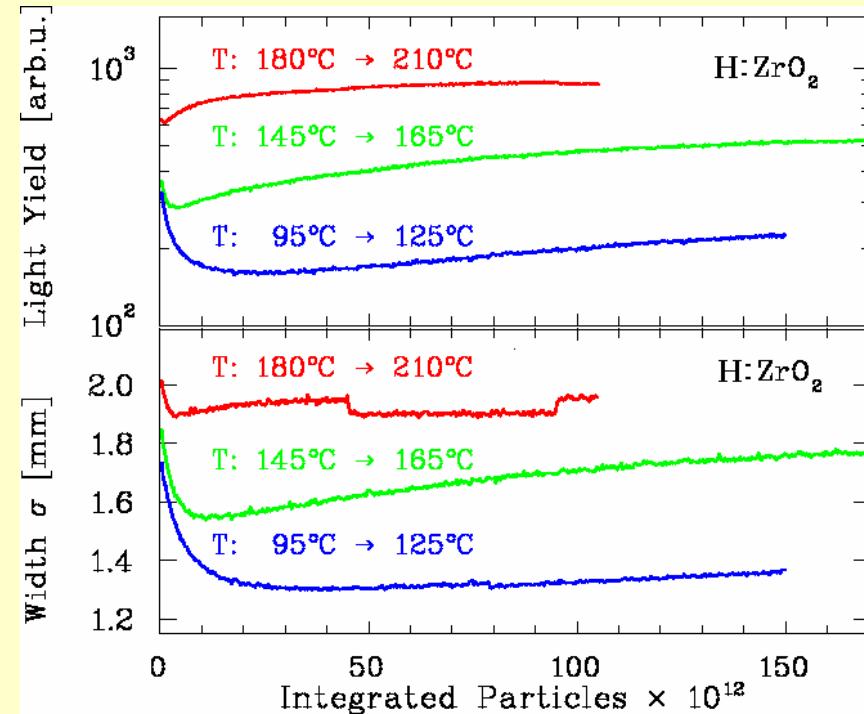
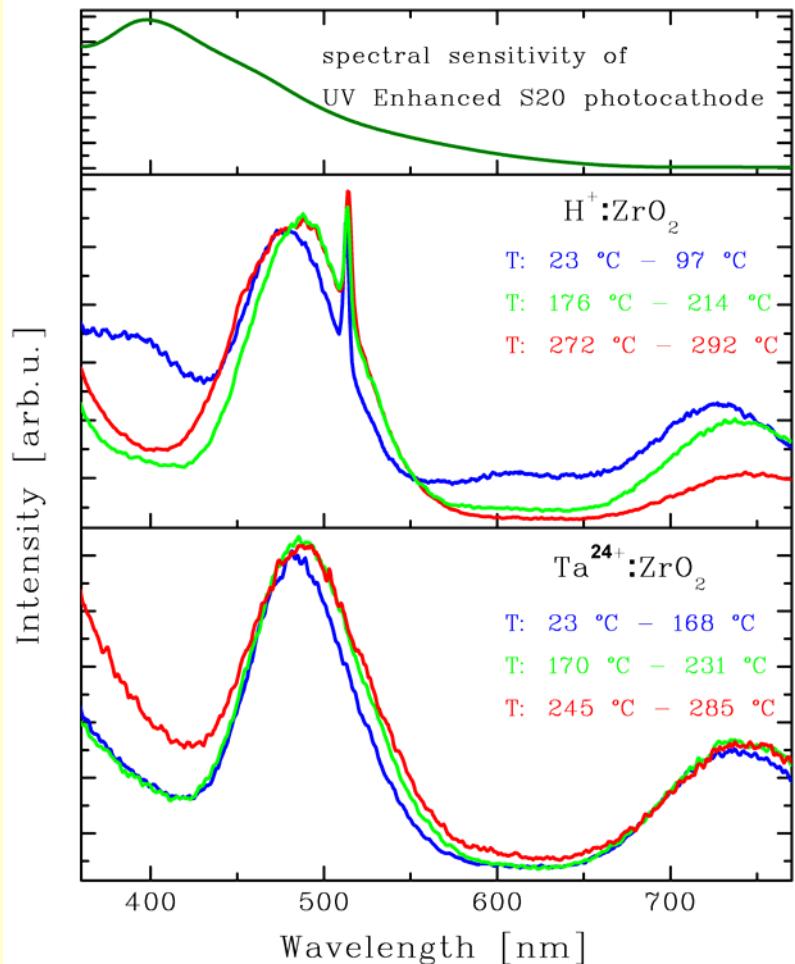
- spectra depend on the ion species → investigation

Beam parameters: H^+ , 4.1×10^{11} Ions/Pulse in 2ms, $\sim 32.8 \mu A$, 2Hz

Ta^{24+} , 8.8×10^9 Ions/Pulse in 100 μs , ~ 0.35 mA, 1Hz



Temperature dependence – medium current



Results:

- Light yield, imaged beam width and spectrum depend on the temperature

Beam parameters: H^+ , 4.1×10^{11} Ions/Pulse in 2ms, ~32.8μA, 2Hz

Ta^{24+} , 8.8×10^9 Ions/Pulse in 100μs, ~0.35mA, 1Hz

Status until summer '09

What has been done:

- Quantitative investigations on different materials
- Materials show different, but reproducible behaviour
- **Profile width depends on scintillator material and the screens temperature!**
- **Spectrum of the screen could depend on the ion species and the temperature!**
- **Light yield AND profile width depend on ion dose!**

ZrO₂, ZrO₂:Mg and undoped Quartz glass show promising results

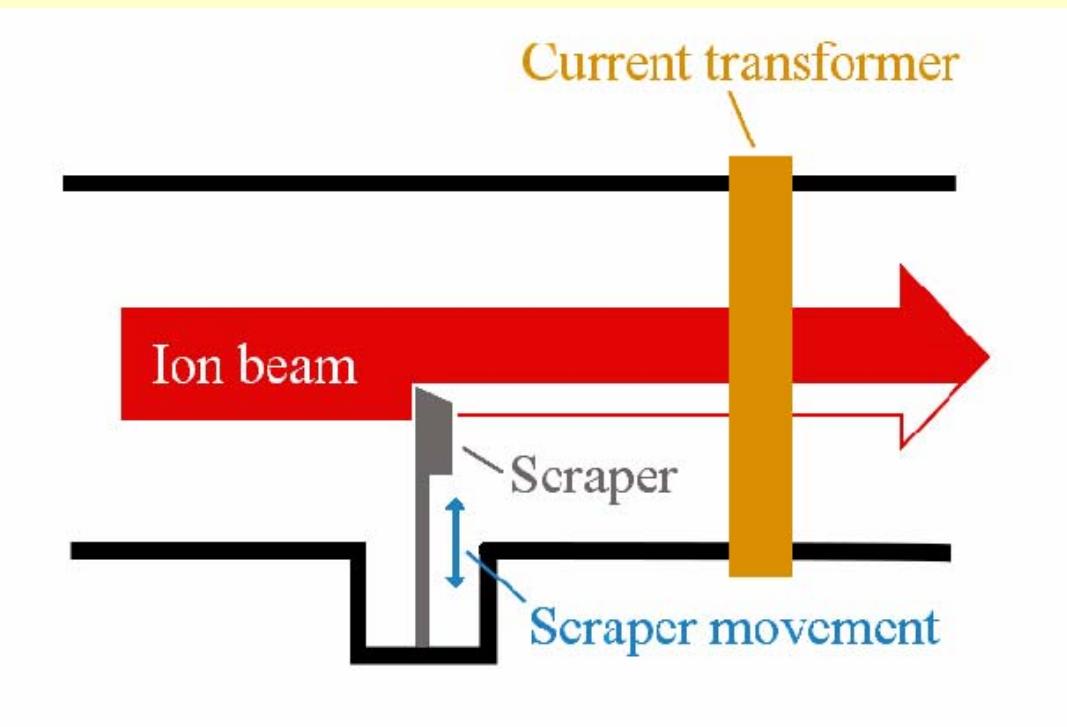
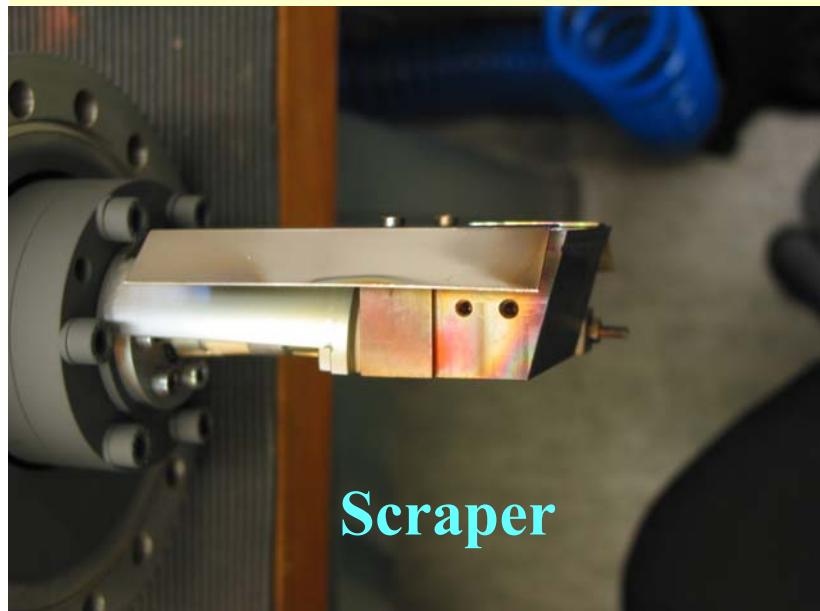
The next steps:

- design of a new data acquisition system
- develop new experiment to determine the "real" beam profil

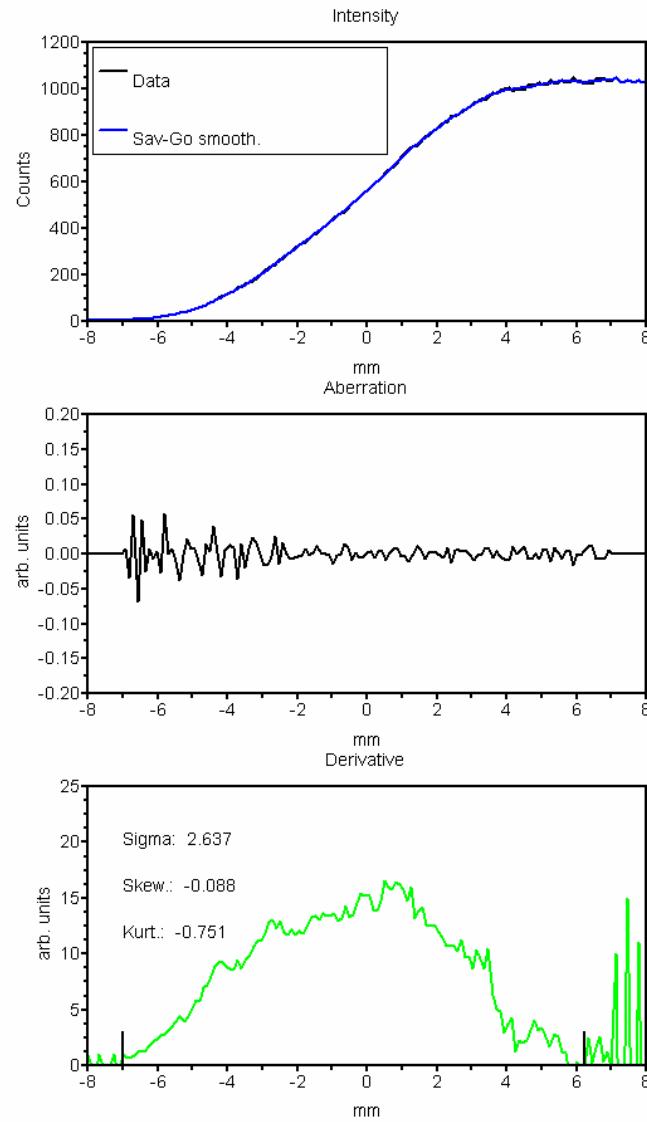
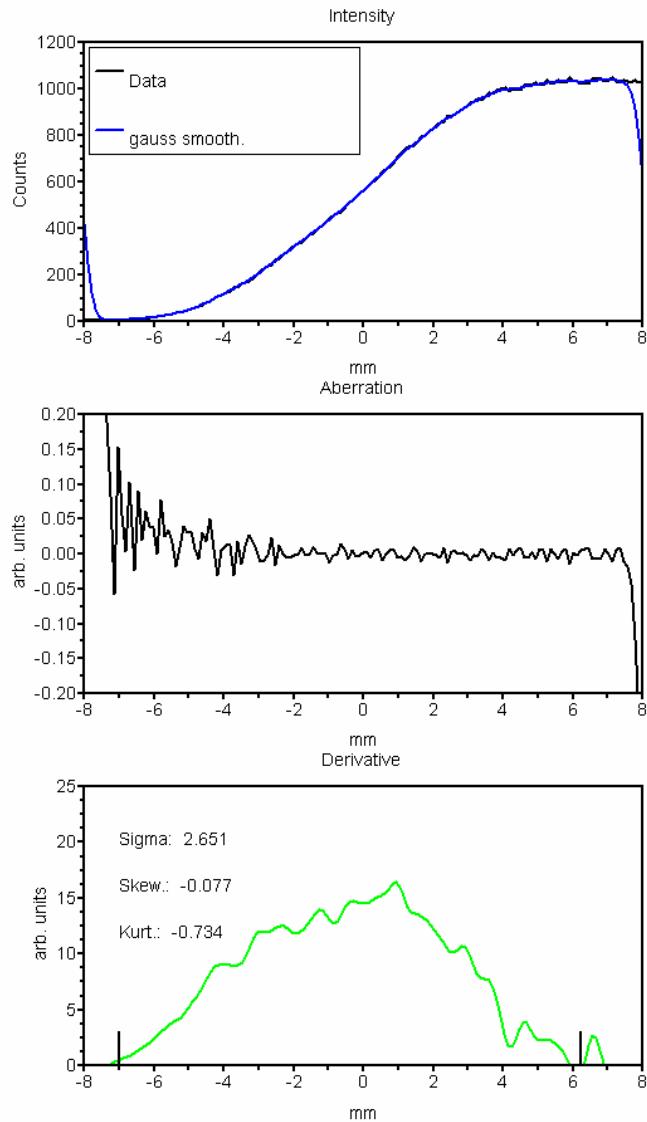
Question

- How can one obtain a trusted beam profile
- What does the "real" ion beam look like

One can try to obtain a horizontal beam profile by using a scraper



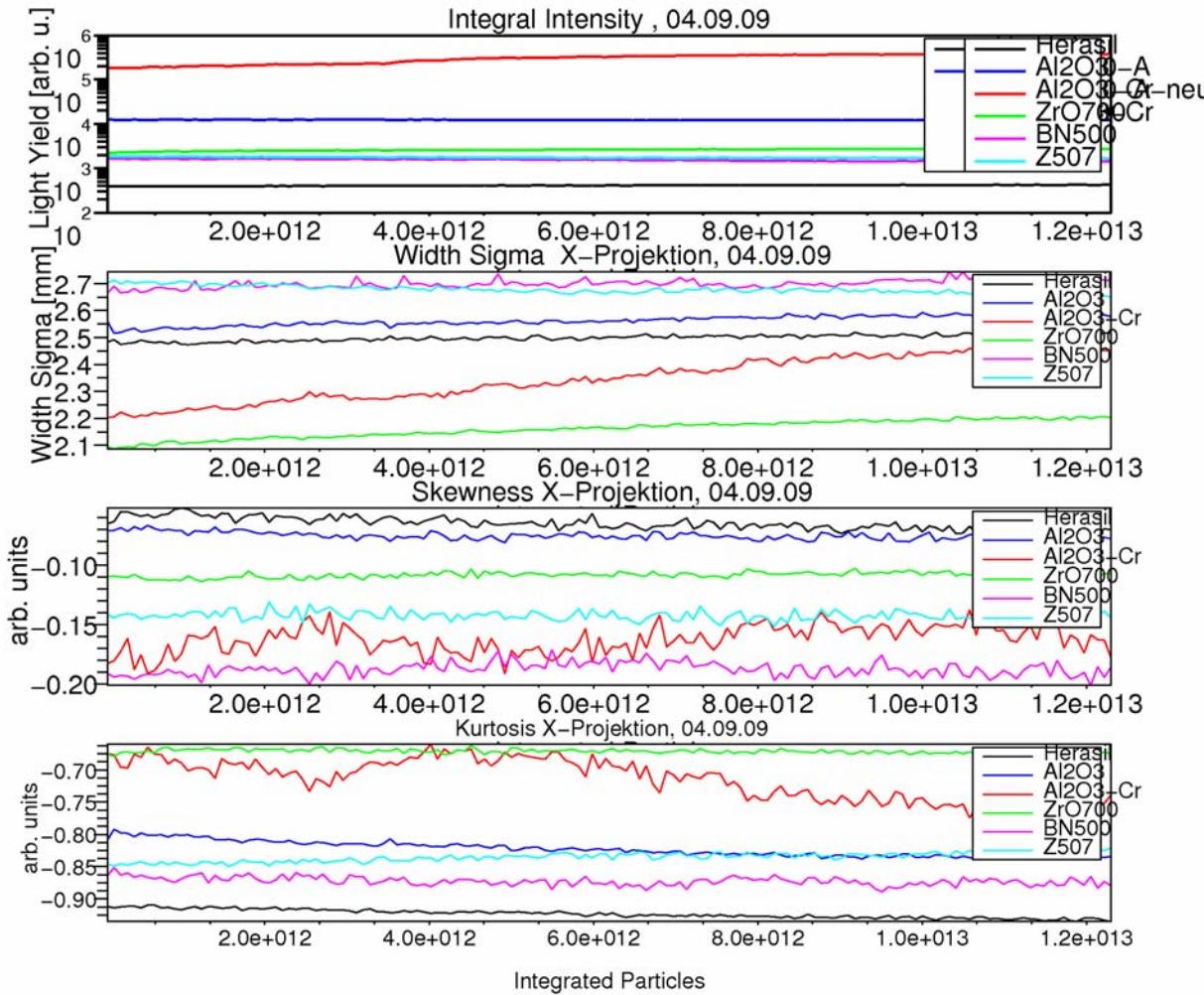
Current data analysis



Results:

- One can obtain a beam profile with a scraper
- The fitting is a critical issue

Current data analysis



Profile values (scraper):

Sigma = 2.64

Skewness = -0.088

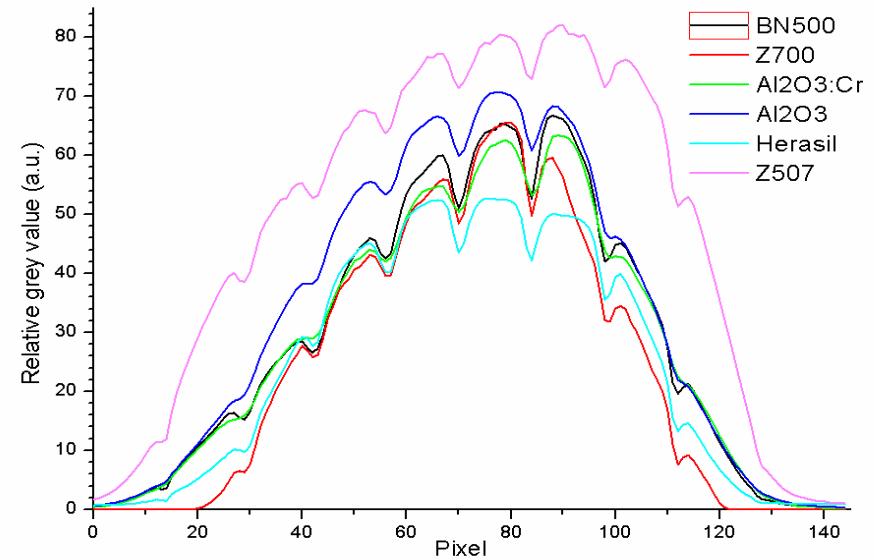
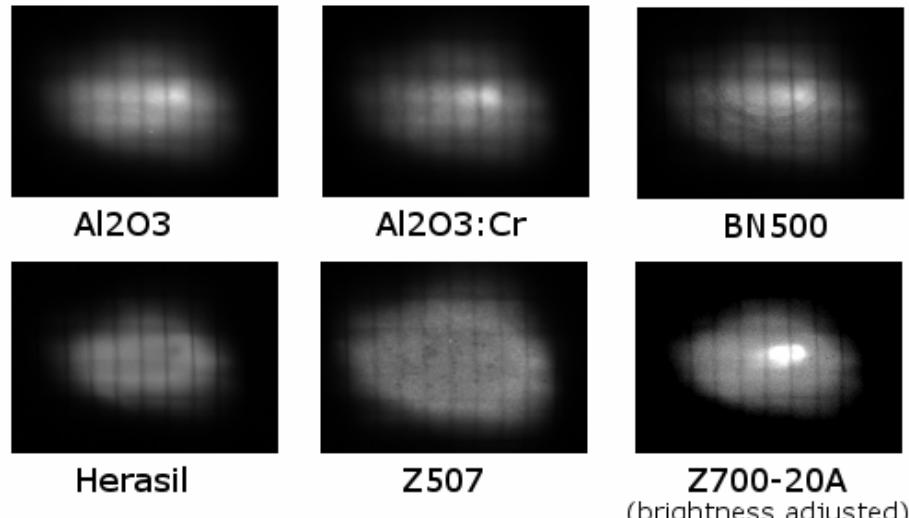
Kurtosis = -0.751

→ Al₂O₃ shows the best agreement with the scraper-values

Results:

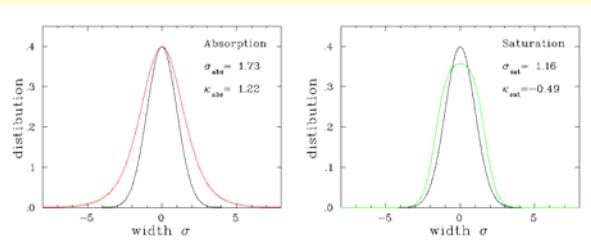
- Obtained values for sigma, skewness and kurtosis agree with the results from the screens

Current data analysis



Results:

- As well as the light transport in the material and the linearity contribute to the signal.
- Linearity seems to dominate (28% difference in sigma)
- First ansatz → convolution



Summary

Data analysis showed:

- One can obtain a beam profile with a scraper
- Obtained values for sigma, skewness and kurtosis agree with the results from the screens
- Light transport in the sample can not explain the difference in beam width

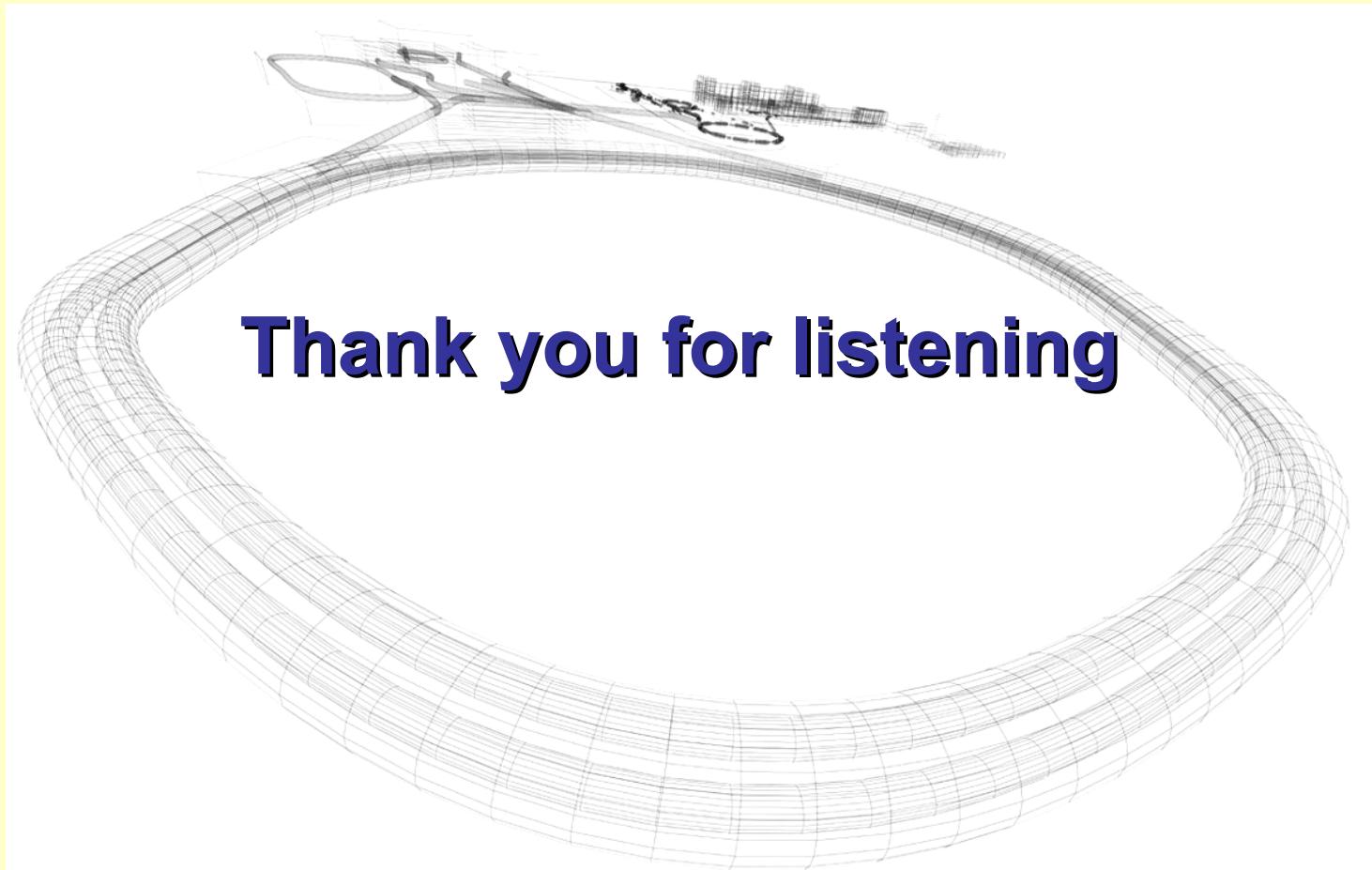
The next steps:

- investigate the influence of the grain size and surface roughness
- analysis of the thermal effects, surface modifications
- further spectroscopic investigations
- approach for a theoretical description of the observed effects
- long-term objective: scintillator for pepperpot-device

⇒ improving knowledge of scintillation process

**Thank you
for listening**





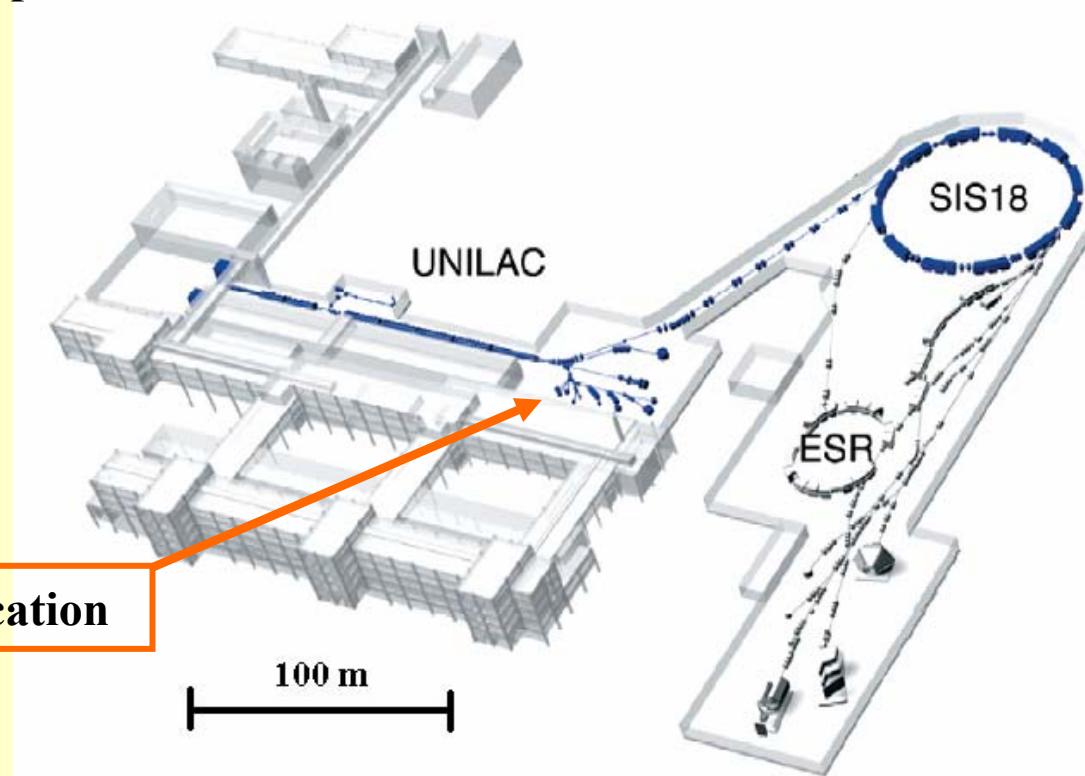
GSI Facility

Linac UNILAC:

- all ions from protons to Uranium
- pulsed currents up to 10 mA
- energies up to 15 MeV/u

Synchrotron SIS18:

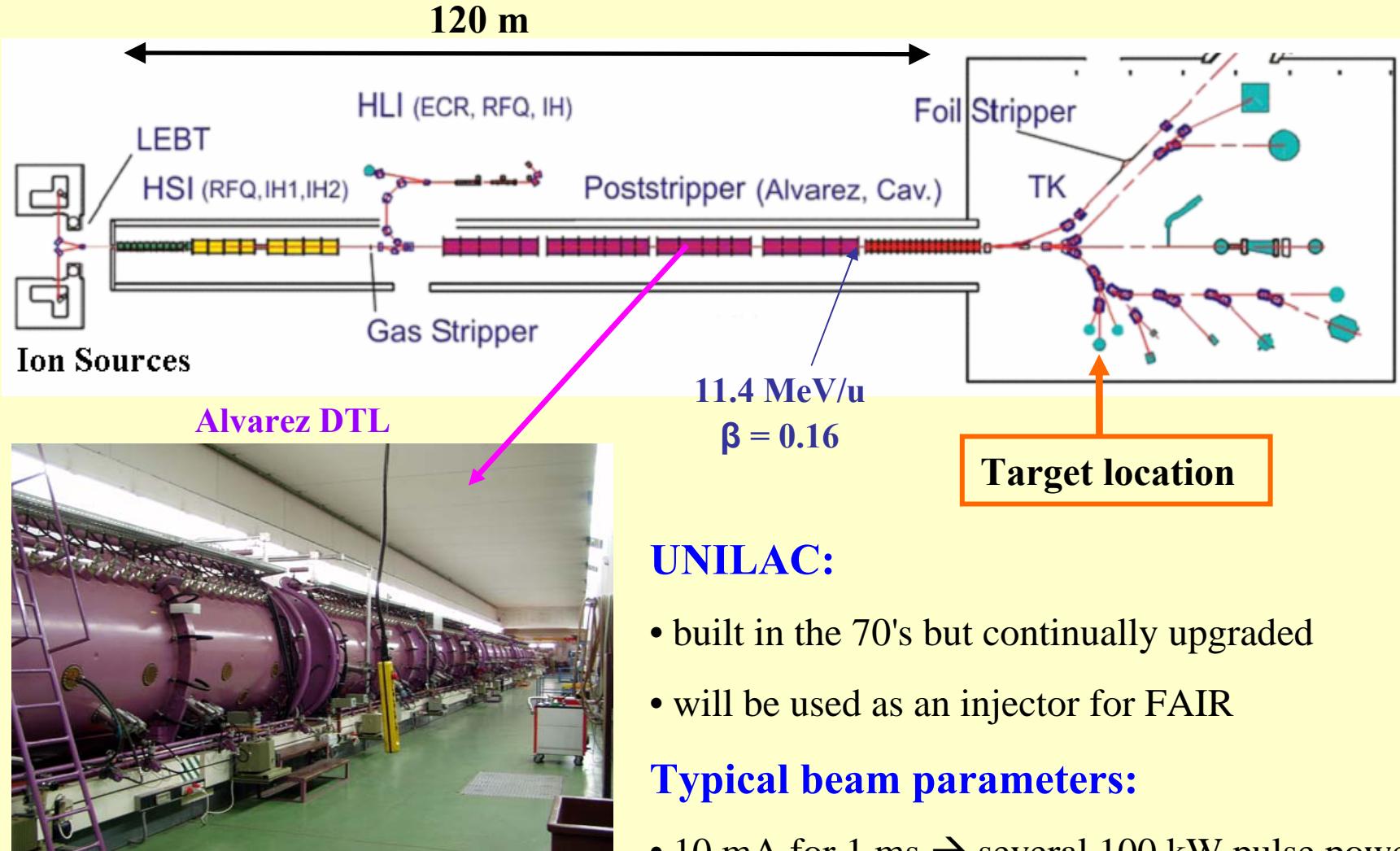
- ions from protons to Uranium
- up to 10^{11} stored particles
- energies up to 4 GeV/u



Future extension:

GSI will be the injector for **FAIR: Facility for Antiproton and Ion Research**, with high beam currents in the UNILAC

The GSI LINAC



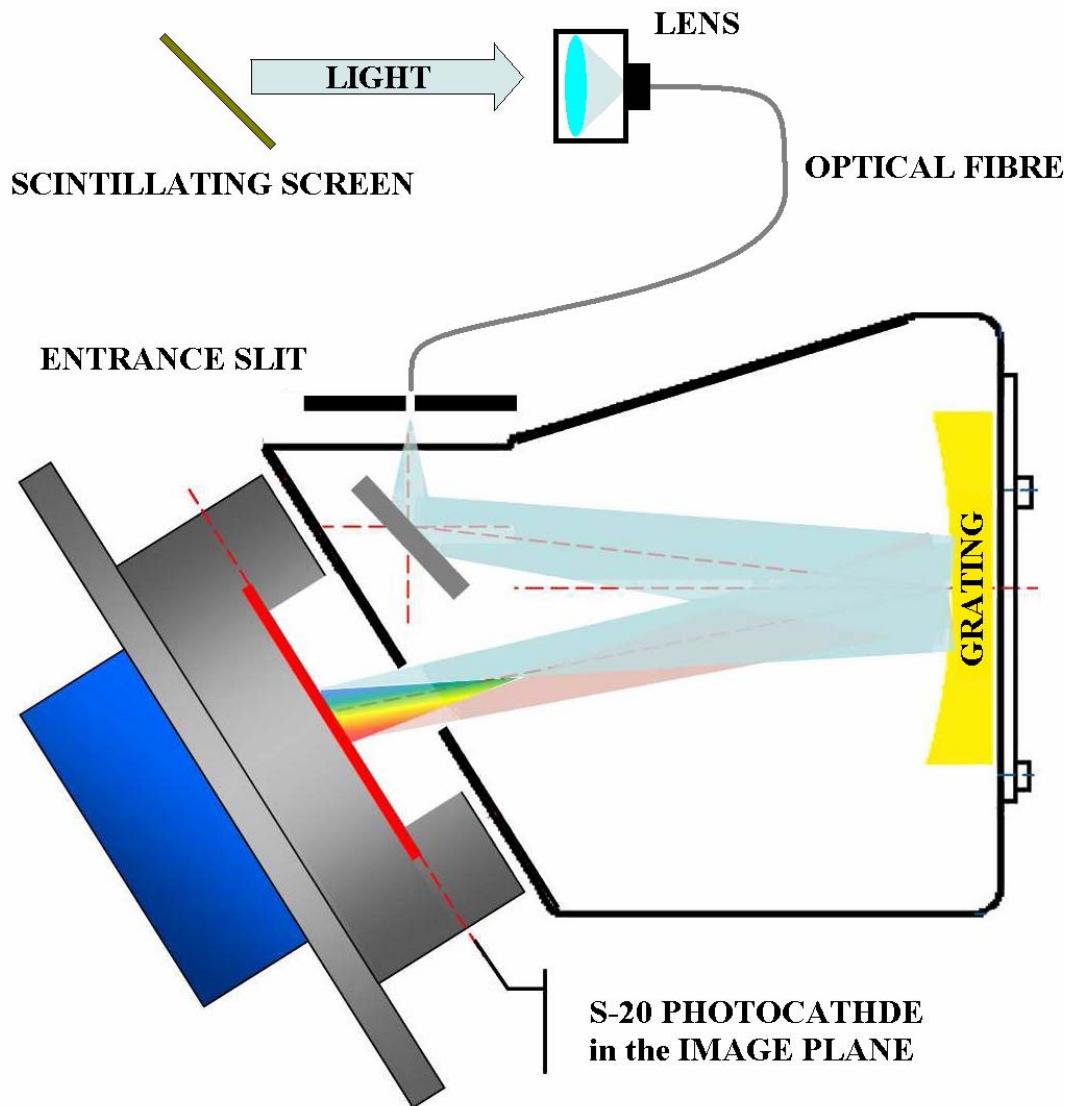
UNILAC:

- built in the 70's but continually upgraded
- will be used as an injector for FAIR

Typical beam parameters:

- 10 mA for 1 ms → several 100 kW pulse power
- up to 50 Hz repetition rate

Spectroscopic studies on scintillation screens



Experimental setup:

Spectrometer:

- HORIBA JOBIN YVON

CP 140-202

- wavelength range: 190-800 nm

average dispersion 50 nm/mm

focal length: 140 mm

Intensified camera:

Photocathode: S20, UV Enhanced
double MCP

Phosphor screen P46

fibre coupled to Basler 311f CCD
Camera

Ocean Optics fibre

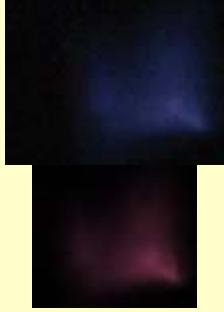
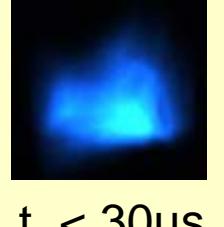
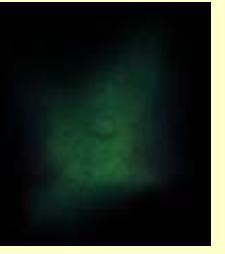
400 μ m



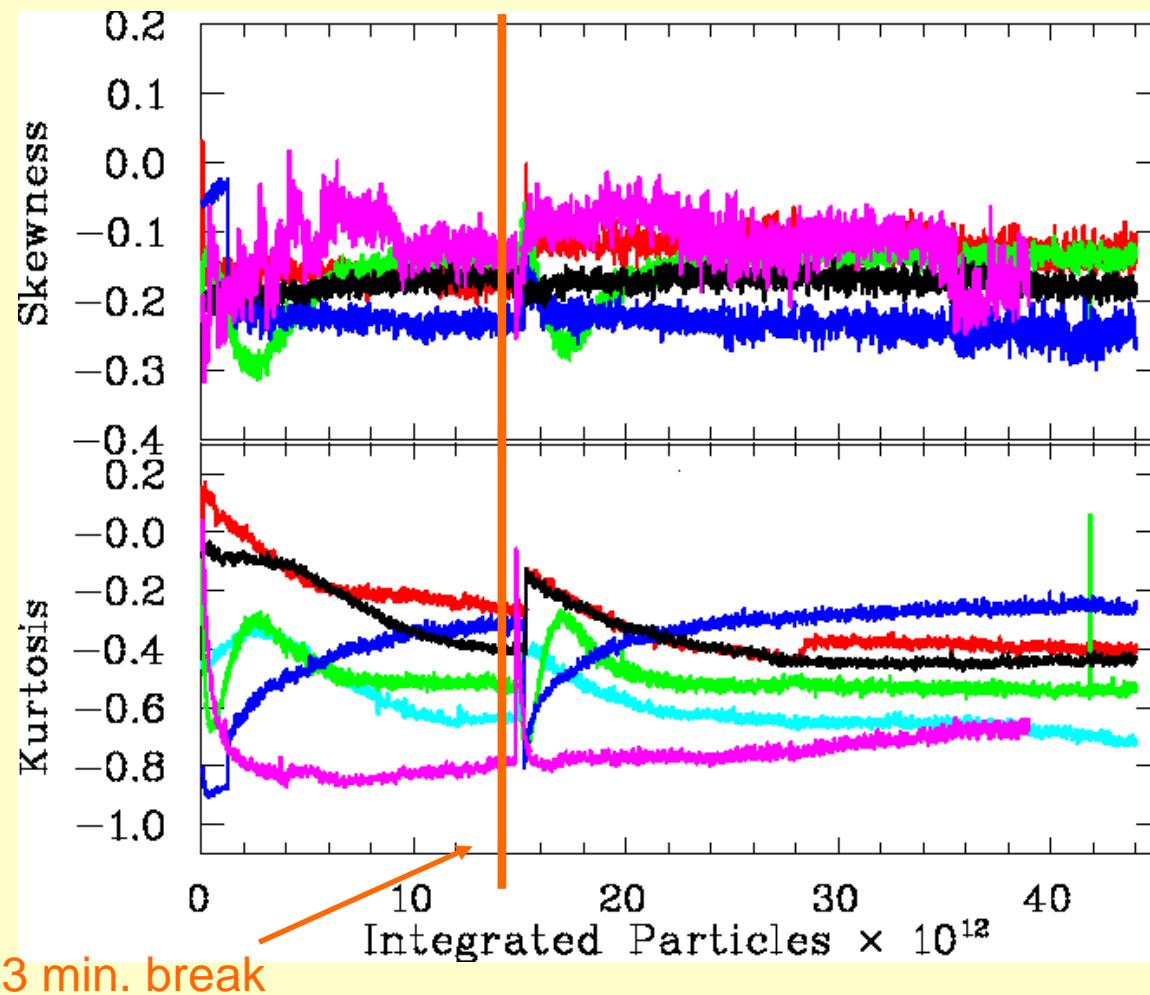
Ion Beams

Ion	Energy [Mev/u]	Beam current	Pulse lenght	ppp	P_{peak}	P_{aver}
$^{12}C^{2+}$	11,4	17nA	100 μ s	$5 \cdot 10^6$	1,1W	138mW
$^{40}Ar^{10+}$	11,4	30 μ A - 1,4mA	100 μ s - 1ms	$1,8 \cdot 10^9$ $- 1 \cdot 10^{11}$	1,3kW - 56,9kW	130mW - 11,3W
$^{64}Ni^{9+}$	5,5 u. 11,4	4,8 μ A - 17 μ A	200 μ s - 5ms	$6,5 \cdot 10^8$ $- 2,4 \cdot 10^{10}$	183W - 677W	37mW - 2,7W
$^{238}U^{28+}$	11,4	30 μ A - 2mA	75 μ s - 500 μ s	$8 \cdot 10^8$ $- 1 \cdot 10^{11}$	2,6kW - 21,7kW	870mW - 4,3W

Colours

	$\text{Al}_2\text{O}_3 : \text{Cr}$	Al_2O_3	Herasil	ZrO_2	$\text{ZrO}_2 : \text{Mg}$	BN
Within the Pulse						
Afterglow	the same colour $t_2: \sim 2\text{ms}$	the same colour $t_2 < 30\mu\text{s}$	 $t_2 < 30\mu\text{s}$	 $t_2 < 30\mu\text{s}$	the same colour $t_2 < 30\mu\text{s}$	 $t_2 < 30\mu\text{s}$

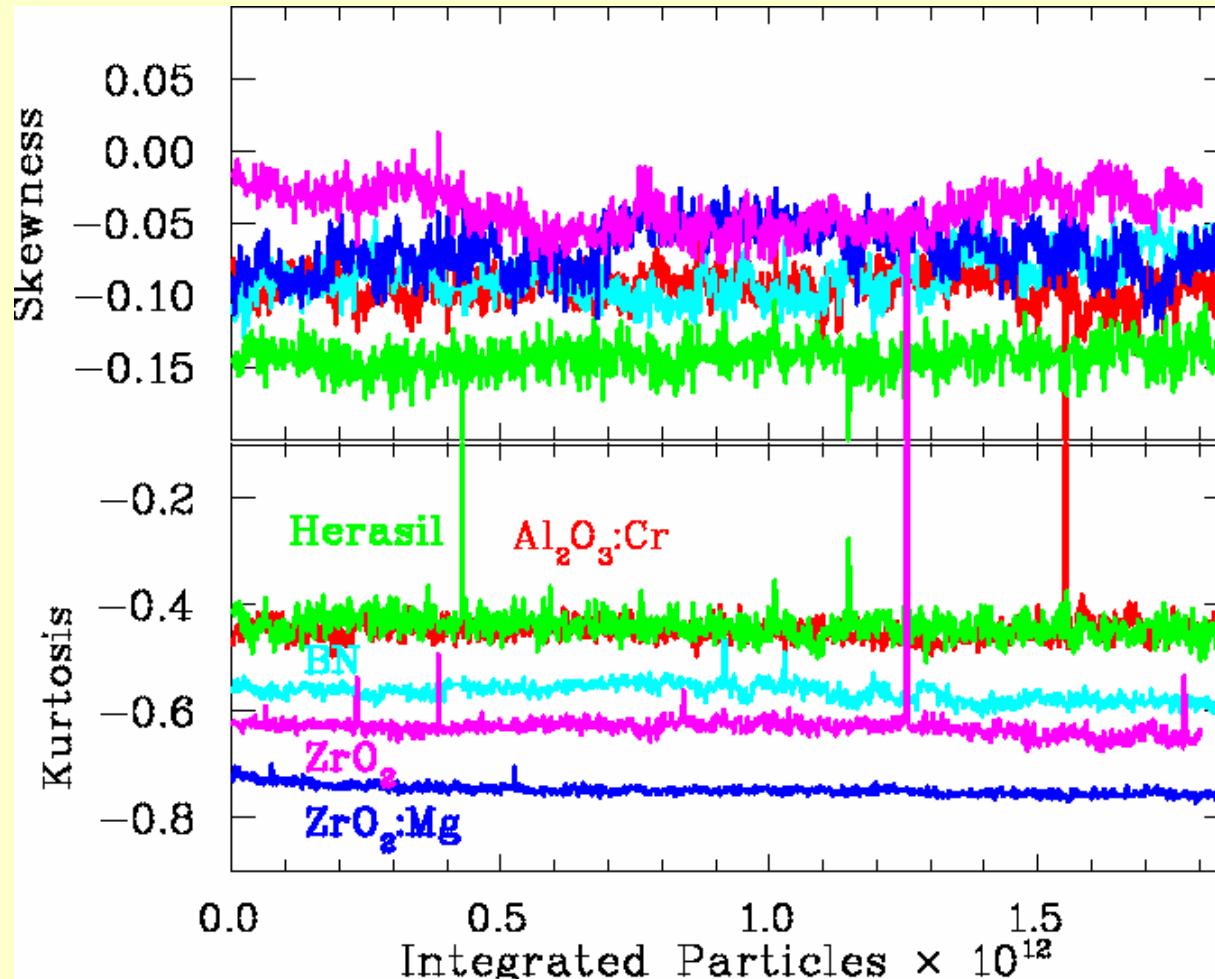
Skewness and Kurtosis @ higher intensity



Beam parameters:

${}^{40}\text{Ar}^{10+}$
 2×10^{10} Ions/Pulse in $100\mu\text{s}$,
~ 0,3mA
2,6Hz

Skewness and kurtosis @ low intensity



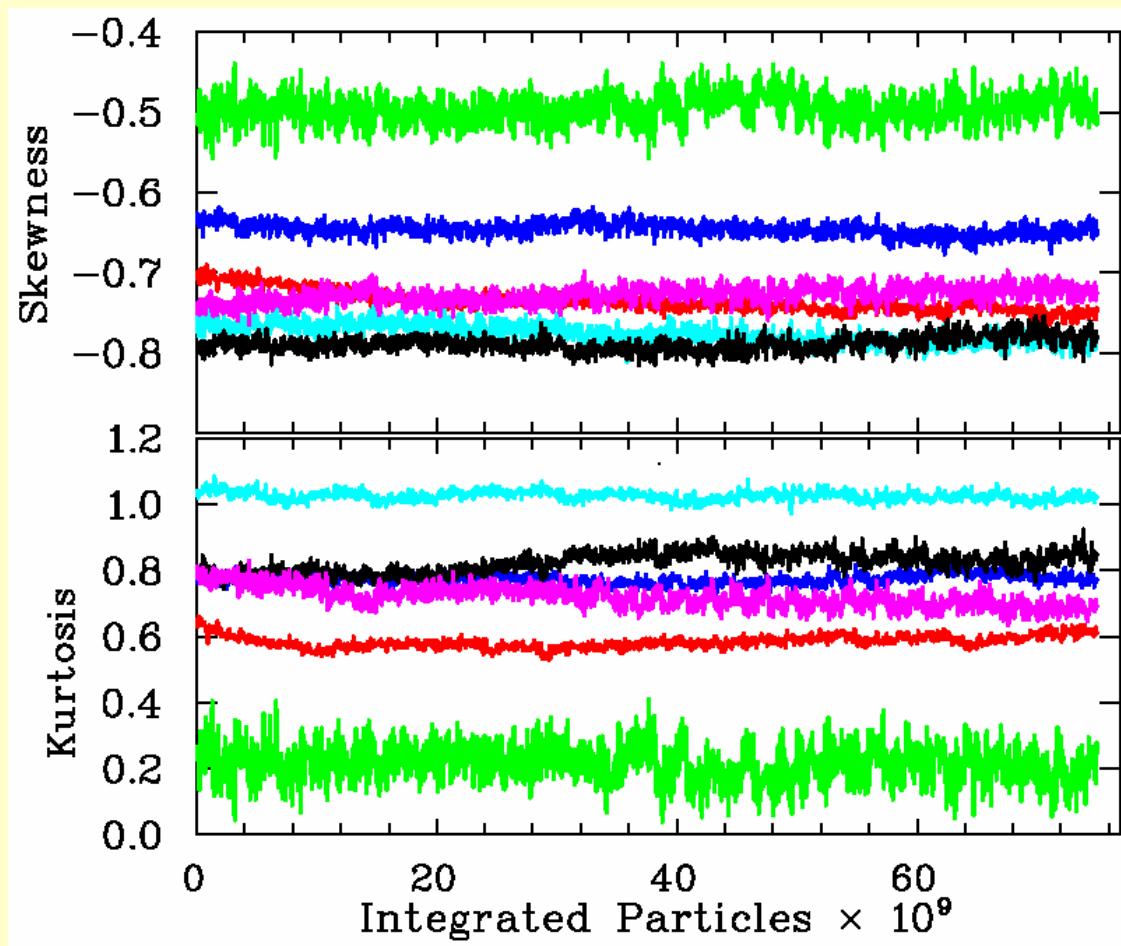
Results:

- reproducible
- different light yield
- different width reading
- different beam shape

Average temperature: 47°C
(backside of $\text{ZrO}_2:\text{Mg}$)

Beam parameters: ${}^{40}\text{Ar}^{10+}$, 2×10^9 Ions/Pulse in 100 μs , ~30 μA , 1Hz, 1000 macro pulses

Skewness and Kurtosis @ very low intensity



Beam parameters:

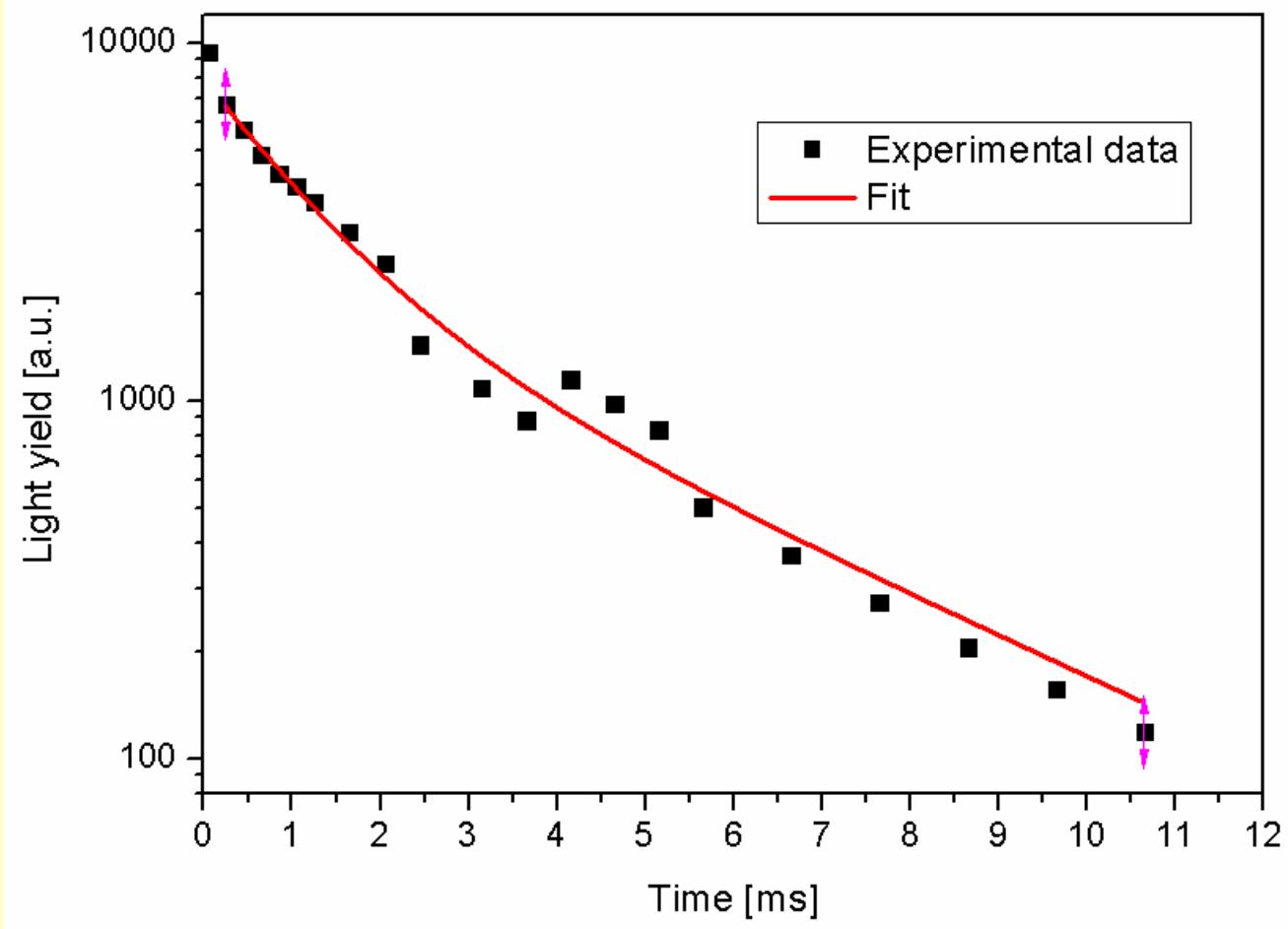
$^{12}\text{C}^{2+}$

5×10^6 Ions/Pulse in 100µs,
~17nA

12,6Hz

Same beam parameters for all samples

Decay time of Al₂O₃:Cr



$$y = a^* e^{(-t/t_1)} + b^* e^{(-t/t_2)}$$

$$t_1: 1.0919 \text{ ms}$$

$$t_2: 3.8263 \text{ ms}$$

there might be faster components

Other materials

$t_2 < 30\mu\text{s}$